

**Search Notes**

Application/Control No.

10/816,979

Examiner

VanThu Nguyen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.05 185.06 x 189.01 189.09	11/2/2005	VTN
	230.03		
	230.06 o		
	230.08 x		
	230.09 x		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as	above	11/2/2005	VTN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search (see print out history)	11/2/2005	VTN